


<b>Search Notes</b>  	<b>Application/Control No.</b>  10593978	<b>Applicant(s)/Patent Under Reexamination</b>  YOSHINO ET AL.
	<b>Examiner</b>  Desai, Naishadh N	<b>Art Unit</b>  2834

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
PLUS search	12/28/2007	NND
IDS, INV searches with several backward and forward citations	12/28/2007	NND
KPO and JPO NPL considered	12/28/2007	NND
Searched 310/254.ccls with keywords	12/28/2007	NND
Consulted examiner Hanh Nguyen for searches in 310	12/28/2007	NND
Updated search based on amendment	11/5/2008	NND

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/N. N. D./  
Examiner, Art Unit 2834